

BS270

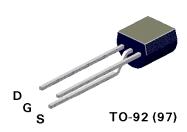
N-Channel Enhancement Mode Field Effect Transistor

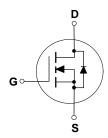
General Description

These N-Channel enhancement mode field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. These products have been designed to minimize on-state resistance while provide rugged, reliable, and fast switching performance. They can be used in most applications requiring up to 500mA DC. These products are particularly suited for low voltage, low current applications such as small servo motor control, power MOSFET gate drivers, and other switching applications.

Features

- 400mA, 60V. $R_{DS(ON)} = 2\Omega$ @ $V_{GS} = 10V$.
- High density cell design for low R_{DS(ON)}.
- Voltage controlled small signal switch.
- Rugged and reliable.
- High saturation current capability.





Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	BS270	Units
V _{DSS}	Drain-Source Voltage	60	V
V_{DGR}	Drain-Gate Voltage ($R_{\rm gs} \leq 1 {\rm M}\Omega$)	60	V
V_{GSS}	Gate-Source Voltage - Continuous	±20	V
	- Non Repetitive (tp < 50µs)	±40	
I _D	Drain Current - Continuous	400	mA
	- Pulsed	2000	
P _D	Maximum Power Dissipation	625	mW
	Derate Above 25°C	5	mW/°C
T_J , T_{STG}	Operating and Storage Temperature Range	-55 to 150	℃
T _L	Maximum Lead Temperature for Soldering Purposes, 1/16" from Case for 10 Seconds	300	°C
THERMA	L CHARACTERISTICS		<u>.</u>
R _{eJA}	Thermal Resistacne, Junction-to-Ambient	200	°C/W

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Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHAI	RACTERISTICS						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{gs} = 0 \text{ V}, I_{D} = 10 \mu\text{A}$		60			V
DSS	Zero Gate Voltage Drain Current	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$				1	μΑ
			T _J = 125°C			500	μA
GSSF	Gate - Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				10	nA
GSSF	Gate - Body Leakage, Reverse	$V_{gs} = -20 \text{ V}, V_{DS} = 0 \text{ V}$				-10	nA
ON CHAR	ACTERISTICS (Note 1)	<u>.</u>				•	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		1	2.1	2.5	V
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{gs} = 10 \text{ V}, I_{D} = 500 \text{ mA}$			1.2	2	Ω
			T _J = 125°C		2	3.5	
		$V_{gs} = 4.5 \text{ V}, I_{D} = 75 \text{ mA}$			1.8	3	
/ _{DS(ON)}	Drain-Source On-Voltage	$V_{GS} = 10 \text{ V}, I_{D} = 500 \text{ mA}$			0.6	1	V
. ,		$V_{GS} = 4.5 \text{ V}, I_{D} = 75 \text{ mA}$			0.14	0.225	
D(ON)	On-State Drain Current	$V_{GS} = 10 \text{ V}, \ V_{DS} \ge 2 V_{DS(on)}$		2000	2700		mA
		$V_{GS} = 4.5 \text{ V}, \ V_{DS} \ge 2 V_{DS(on)}$		400	600		
) _{FS}	Forward Transconductance	$V_{DS} \ge 2 V_{DS(on)}, I_D = 200 \text{ mA}$		100	320		mS
OYNAMIC	CHARACTERISTICS						
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$			20	50	pF
Coss	Output Capacitance				11	25	pF
O _{rss}	Reverse Transfer Capacitance				4	5	pF
SWITCHIN	G CHARACTERISTICS (Note 1)						
on	Turn-On Time	$V_{DD} = 30 \text{ V}, \ I_D = 500 \text{ m A},$ $V_{GS} = 10 \text{ V}, R_{GEN} = 25 \Omega$				10	ns
off	Turn-Off Time					10	ns
DRAIN-SO	URCE DIODE CHARACTERISTICS AND	MAXIMUM RATINGS					
S	Maximum Continuous Drain-Source Diode Forward Current					400	mA
SM	Maximum Pulsed Drain-Source Diode Forward Current				2000	mA	
/ _{SD}	Drain-Source Diode Forward Voltage V _{GS} = 0 V, I _S = 400 mA (Note 1)			0.88	1.2	V	

Note: 1. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%.

Typical Electrical Characteristics

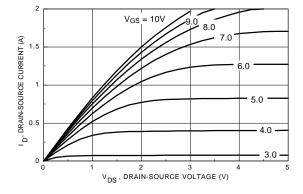


Figure 1. On-Region Characteristics.

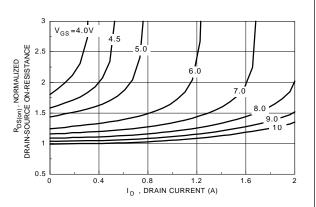


Figure 2. On-Resistance Variation with Gate Voltage and Drain Current.

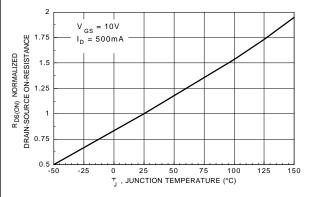


Figure 3. On-Resistance Variation with Temperature.

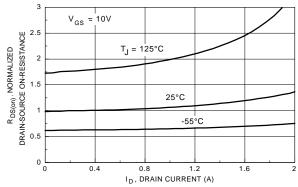


Figure 4. On-Resistance Variation with Drain Current and Temperature.

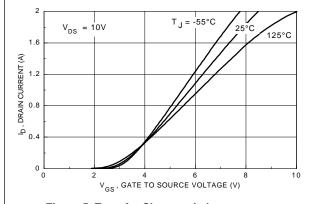


Figure 5. Transfer Characteristics.

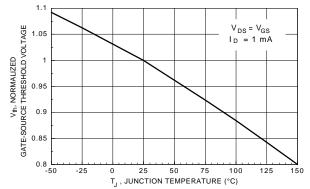


Figure 6. Gate Threshold Variation with Temperature.

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Typical Electrical Characteristics (continued)

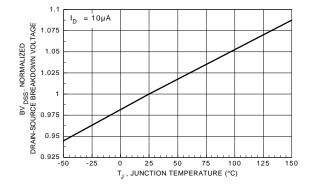


Figure 7. Breakdown Voltage Variation with Temperature.

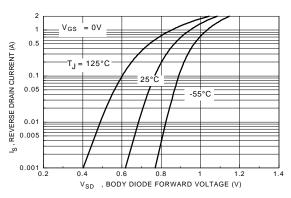


Figure 8. Body Diode Forward Voltage Variation with Current and Temperature.

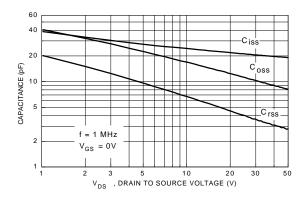


Figure 9. Capacitance Characteristics.

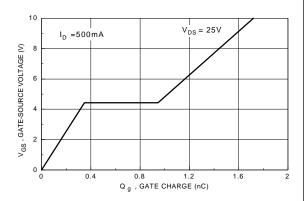


Figure 10. Gate Charge Characteristics.

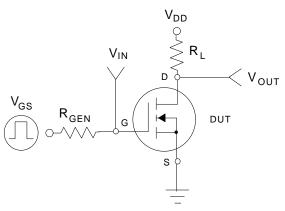


Figure 11. Switching Test Circuit.

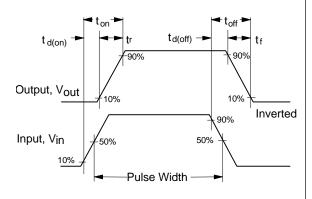


Figure 12. Switching Waveforms.

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Typical Electrical Characteristics (continued)

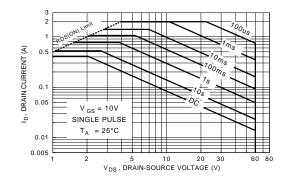


Figure 13. Maximum Safe Operating Area.

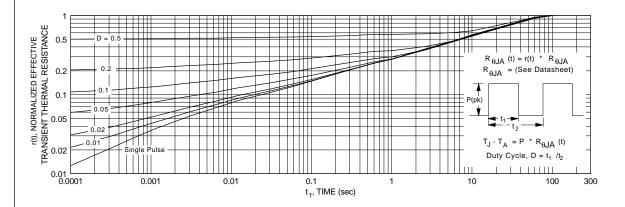
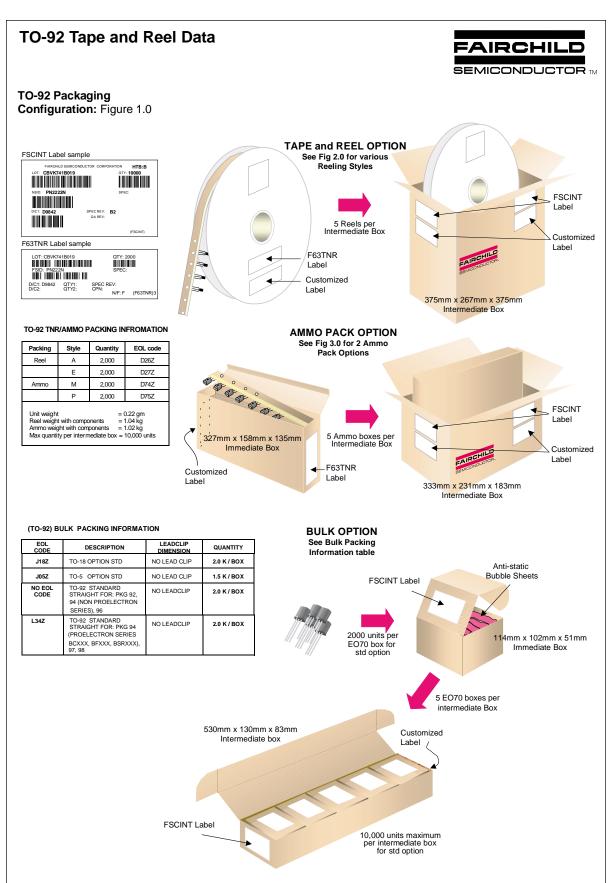


Figure 14. Transient Thermal Response Curve.

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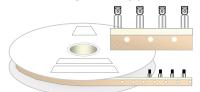


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TO-92 Tape and Reel Data, continued

TO-92 Reeling Style Configuration: Figure 2.0

Machine Option "A" (H)

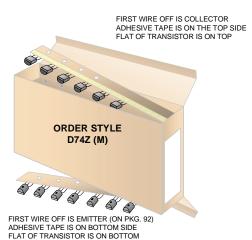


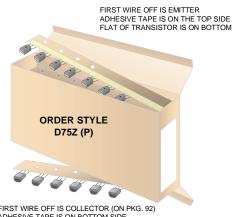
Style "A", D26Z, D70Z (s/h)

Machine Option "E" (J)

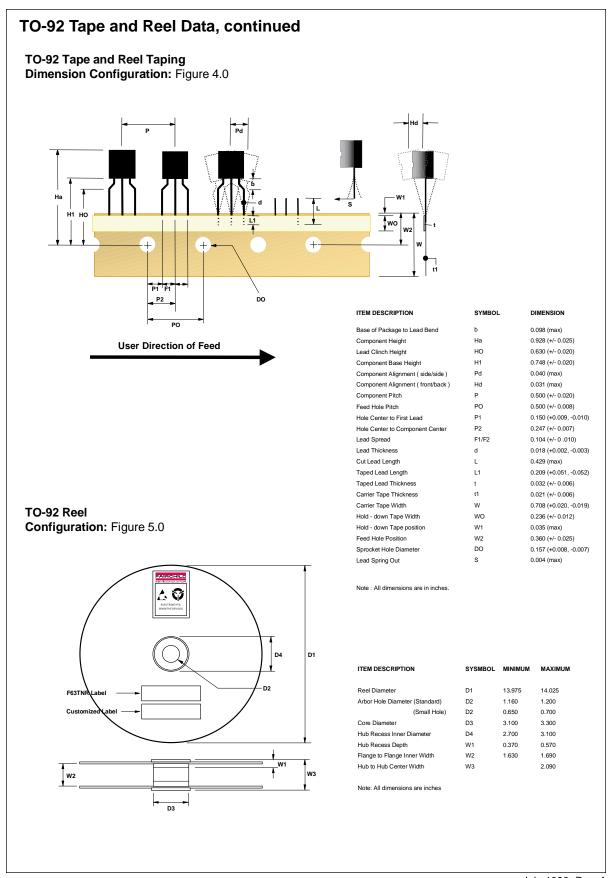
Style "E", D27Z, D71Z (s/h)

TO-92 Radial Ammo Packaging Configuration: Figure 3.0





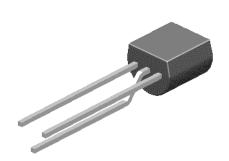
FIRST WIRE OFF IS COLLECTOR (ON PKG. 92) ADHESIVE TAPE IS ON BOTTOM SIDE FLAT OF TRANSISTOR IS ON TOP

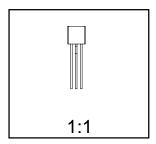


TO-92 Package Dimensions



TO-92; TO-18 Reverse Lead Form (J35Z Option) (FS PKG Code 92, 94, 96)

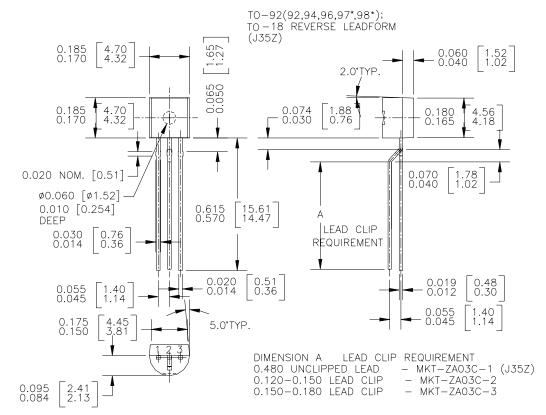




Scale 1:1 on letter size paper

Dimensions shown below are in: inches [millimeters]

Part Weight per unit (gram): 0.22



Note: All package 97 or 98 transistors are leadformed to this configuration prior to bulk shipment. Order L34Z option if in-line leads are preferred on package 97 or 98.

January 2000, Rev. B

^{*} Standard Option on 97 & 98 package code

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Rev. G